

<b>Notice of References Cited</b>	Application/Control No. 10/500,985	Applicant(s)/Patent Under Reexamination HEYDEN ET AL.	
	Examiner John Wahnkyo Lee	Art Unit 2624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,073,963 A	12-1991	Sammons et al.	382/128
*	B	US-7,155,050 B1	12-2006	Sloge et al.	382/133
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 01/07920	07-2000	US	Nguyen et al.	G01 N 33/68
	O					
	P					
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Jossó et al., "Automatic 2-D Gel Registration Using Distance Minimisation of Image Morphing," 19-21 July 2000, IEEE, pages 357-361
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.